Attorney's Docket No.: 07977-280001 / US5027

THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Yamazaki, et al Art Unit: 2825

Serial No.: 09/894,950 Examiner: Caridad Everhart

Filed: June 27, 2001 Confirmation No.: 6263

Title : SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

Commissioner for Patents

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Alexandria, VA 22313-1450

JUL 28 2004

INFORMATION DISCLOSURE STATEMENT

TECH CENTER 2800

Applicants submit the references listed on the attached form PTO-1449.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. A check for \$180 in payment of the late submission fee of §1.17(p) is enclosed. Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: July 21, 2004

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U		oplicant	Applicant Yamazaki, et al	ari/FD)
	(Use several sheets if necessary)	Filing Date June 27, 2001	HEU Group Art Unit 2825	
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91940			U.S. Pate	ent Documents			
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Ciass	CENTER 2800 Subclass	Filing Date If Appropriate
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	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)				
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	AQ			
	AR			
	AS			
	AT			

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EXAMINER: Initials citation considered. Draw line through citation if no	ot in conformance and not considered. Include copy of this form with